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U.S. Departn	mmerce, Patent and	Atty. Docket	No. 10.	Serial Do.	110					
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			U.S.	Patent Documents			···			
*Examiner Initial		Document Number	Date	Name	Class Subclass		Filing Date If Appropriate			
/SKH/	AA	US 20010030323	10/18/2001	Ikeda						
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			Foreign	n Patent Documents	——————————————————————————————————————	I				
				•		-	Translation			
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7SKH/	AL	1-94670	04/13/1989	Japan				x		
/SKH/	AM	1-189632	07/28/1989	Japan				$\frac{1}{x}$		
/SKH/	AN	10-98190	04/14/1998	Japan				x		
/SKH/	AO	2000-147574	05/26/2000	Japan	 			x		
	AP					•		+		
		OTHER A	RT (Including A	Author, Title, Date, Per	rtinent Pages, E	tc.)				
	AQ	Patent Abstracts of	Japan, Publicat	tion No. 01-094670, 0	4/13/1989, 1 p.					
AR Patent Abstracts of Japan, Publication No. 01-189632, 07/28/1989, 1 p.										
	AS Patent Abstracts of Japan, Publication No. 10-098190, 04/14/1998, 2 pp.									
Examiner	/Sarah I	Harding/	Date Considere	ed 03/30/2007		-				
*EXAMINER citation if not	: Initial i	f reference considere	d, whether or no lered. Include c	ot citation is in conformation of this form with	mance with MP.	EP 609; Draw ation to applic	line through	<u> </u>		

IAP20 Rec'd PCT/PTO 13 APR 2006

U.S. Departme	ent of Co	mmerce, Patent an	Atty. Docket No. 11/Smr 10.819						
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*Examiner Initial		Document Number	Date	Name	Class Subclass		Filing Date If Appropriate		
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	AO								
	AP								
<u> </u>		OTHER	ART (Including Aut	thor, Title, Date, Po	ertinent Pages, E	tc.)			
/SKH/	AQ	Patent Abstracts	of Japan, 2000-1475	574, 05/26/2000, 1	p .				
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	AS			<u> </u>					
Examiner	/Sara	ah Harding/ Date Considered 03/30/2007							
*EXAMINER citation if not	: Initial i	f reference consid mance and not cor	ered, whether or not isidered. Include cop	citation is in confo	rmance with MP your communic	EP 609; Dravation to appl	v line through icant.		